

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









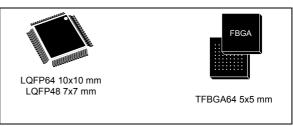
STM32L053C6 STM32L053C8 STM32L053R6 STM32L053R8

Ultra-low-power 32-bit MCU ARM®-based Cortex®-M0+, up to 64KB Flash, 8KB SRAM, 2KB EEPROM, LCD, USB, ADC, DAC

Datasheet - production data

Features

- Ultra-low-power platform
 - 1.65 V to 3.6 V power supply
 - -40 to 125 °C temperature range
 - 0.27 μA Standby mode (2 wakeup pins)
 - 0.4 µA Stop mode (16 wakeup lines)
 - 0.8 μA Stop mode + RTC + 8 KB RAM retention
 - 88 μA/MHz in Run mode
 - 3.5 µs wakeup time (from RAM)
 - 5 μs wakeup time (from Flash memory)
- Core: ARM® 32-bit Cortex®-M0+ with MPU
 - From 32 kHz up to 32 MHz max.
 - 0.95 DMIPS/MHz
- Reset and supply management
 - Ultra-safe, low-power BOR (brownout reset) with 5 selectable thresholds
 - Ultra-low-power POR/PDR
 - Programmable voltage detector (PVD)
- Clock sources
 - 1 to 25 MHz crystal oscillator
 - 32 kHz oscillator for RTC with calibration
 - High speed internal 16 MHz factory-trimmed RC (+/- 1%)
 - Internal low-power 37 kHz RC
 - Internal multispeed low-power 65 kHz to 4.2 MHz RC
 - PLL for CPU clock
- Pre-programmed bootloader
 - USART, SPI supported
- · Development support
 - Serial wire debug supported
- Up to 51 fast I/Os (45 I/Os 5V tolerant)
- Memories
 - Up to 64 KB Flash memory with ECC
 - 8KB RAM
 - 2 KB of data EEPROM with ECC
 - 20-byte backup register
 - Sector protection against R/W operation
- LCD driver for up to 8×28segments
 - Support contrast adjustment
 - Support blinking mode
 - Step-up converted on board



- Rich Analog peripherals
 - 12-bit ADC 1.14 Msps up to 16 channels (down to 1.65 V)
 - 12-bit 1 channel DAC with output buffers (down to 1.8 V)
 - 2x ultra-low-power comparators (window mode and wake up capability, down to 1.65 V)
- Up to 24 capacitive sensing channels supporting touchkey, linear and rotary touch sensors
- 7-channel DMA controller, supporting ADC, SPI, I2C, USART, DAC, Timers
- 8x peripheral communication interfaces
 - 1x USB 2.0 crystal-less, battery charging detection and LPM
 - 2x USART (ISO 7816, IrDA), 1x UART (low power)
 - Up to 4x SPI 16 Mbits/s
 - 2x I2C (SMBus/PMBus)
- 9x timers: 1x 16-bit with up to 4 channels, 2x 16-bit with up to 2 channels, 1x 16-bit ultra-low-power timer, 1x SysTick, 1x RTC, 1x 16-bit basic for DAC, and 2x watchdogs (independent/window)
- CRC calculation unit, 96-bit unique ID
- True RNG and firewall protection
- All packages are ECOPACK[®]2

Contents

1	Intro	duction	9
2	Desc	cription	10
	2.1	Device overview	11
	2.2	Ultra-low-power device continuum	13
3	Fund	ctional overview	14
	3.1	Low-power modes	14
	3.2	Interconnect matrix	19
	3.3	ARM® Cortex®-M0+ core with MPU	20
	3.4	Reset and supply management	21
		3.4.1 Power supply schemes	
		3.4.2 Power supply supervisor	21
		3.4.3 Voltage regulator	22
	3.5	Clock management	22
	3.6	Low-power real-time clock and backup registers	25
	3.7	General-purpose inputs/outputs (GPIOs)	25
	3.8	Memories	26
	3.9	Boot modes	26
	3.10	Direct memory access (DMA)	27
	3.11	Liquid crystal display (LCD)	27
	3.12	Analog-to-digital converter (ADC)	27
	3.13	Temperature sensor	28
		3.13.1 Internal voltage reference (V _{REFINT})	28
		3.13.2 V _{LCD} voltage monitoring	
	3.14	Digital-to-analog converter (DAC)	29
	3.15	Ultra-low-power comparators and reference voltage	29
	3.16	System configuration controller	30
	3.17	Touch sensing controller (TSC)	30
	3.18	Timers and watchdogs	31
		3.18.1 General-purpose timers (TIM2, TIM21 and TIM22)	
		3.18.2 Low-power Timer (LPTIM)	32



		3.18.3	Basic timer (TIM6)	. 32
		3.18.4	SysTick timer	. 32
		3.18.5	Independent watchdog (IWDG)	. 32
		3.18.6	Window watchdog (WWDG)	. 33
	3.19	Commi	unication interfaces	33
		3.19.1	I2C bus	. 33
		3.19.2	Universal synchronous/asynchronous receiver transmitter (USART) .	. 34
		3.19.3	Low-power universal asynchronous receiver transmitter (LPUART)	. 34
		3.19.4	Serial peripheral interface (SPI)/Inter-integrated sound (I2S)	. 35
		3.19.5	Universal serial bus (USB)	. 36
	3.20	Clock r	ecovery system (CRS)	36
	3.21	Cyclic r	redundancy check (CRC) calculation unit	36
	3.22	Serial v	vire debug port (SW-DP)	36
4	Pin d	lescript	ions	37
5	Mam	orv mar	oping	49
•	Wicili	ory map	philig	73
6	Elect	rical ch	aracteristics	50
		_		
	6.1		eter conditions	
	6.1	6.1.1	Minimum and maximum values	. 50
	6.1	6.1.1 6.1.2	Minimum and maximum values	. 50 . 50
	6.1	6.1.1 6.1.2 6.1.3	Minimum and maximum values	. 50 . 50 . 50
	6.1	6.1.1 6.1.2 6.1.3 6.1.4	Minimum and maximum values Typical values Typical curves Loading capacitor	. 50 . 50 . 50
	6.1	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage	. 50 . 50 . 50 . 50
	6.1	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme	. 50 . 50 . 50 . 50 . 50
	6.1	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme	. 50 . 50 . 50 . 50 . 51 . 52
		6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement	. 50 . 50 . 50 . 50 . 51 . 52
	6.2	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8 Absolut	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement te maximum ratings	. 50 . 50 . 50 . 50 . 51 . 52 . 52
		6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8 Absolution	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement te maximum ratings ing conditions	. 50 . 50 . 50 . 50 . 51 . 52 . 52 53
	6.2	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8 Absoluti Operati 6.3.1	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement te maximum ratings ing conditions General operating conditions	. 500 . 500 . 500 . 500 . 511 . 522 . 533 555
	6.2	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8 Absolut Operati 6.3.1 6.3.2	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement te maximum ratings ing conditions General operating conditions Embedded reset and power control block characteristics	. 50 . 50 . 50 . 50 . 51 . 52 . 52 . 53 . 55 . 55
	6.2	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8 Absolution Operation 6.3.1 6.3.2 6.3.3	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement te maximum ratings ing conditions General operating conditions Embedded reset and power control block characteristics Embedded internal reference voltage	. 50 . 50 . 50 . 50 . 51 . 52 . 53 . 55 . 55 . 55
	6.2	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8 Absolution Operation 6.3.1 6.3.2 6.3.3 6.3.4	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement te maximum ratings ing conditions General operating conditions Embedded reset and power control block characteristics Embedded internal reference voltage Supply current characteristics	. 50 . 50 . 50 . 50 . 51 . 52 . 52 . 55 . 55 . 55 . 55
	6.2	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8 Absolut Operati 6.3.1 6.3.2 6.3.3 6.3.4 6.3.5	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement te maximum ratings ing conditions General operating conditions Embedded reset and power control block characteristics Embedded internal reference voltage Supply current characteristics Wakeup time from low-power mode	. 50 . 50 . 50 . 50 . 51 . 52 . 52 . 55 . 57 . 58 . 59
	6.2	6.1.1 6.1.2 6.1.3 6.1.4 6.1.5 6.1.6 6.1.7 6.1.8 Absolution Operation 6.3.1 6.3.2 6.3.3 6.3.4	Minimum and maximum values Typical values Typical curves Loading capacitor Pin input voltage Power supply scheme Optional LCD power supply scheme Current consumption measurement te maximum ratings ing conditions General operating conditions Embedded reset and power control block characteristics Embedded internal reference voltage Supply current characteristics	. 50 . 50 . 50 . 50 . 51 . 52 . 52 . 55 . 55 . 55 . 57 . 58 . 70



		6.3.8	PLL characteristics79
		6.3.9	Memory characteristics80
		6.3.10	EMC characteristics
		6.3.11	Electrical sensitivity characteristics
		6.3.12	I/O current injection characteristics
		6.3.13	I/O port characteristics
		6.3.14	NRST pin characteristics
		6.3.15	12-bit ADC characteristics
		6.3.16	DAC electrical characteristics
		6.3.17	Temperature sensor characteristics
		6.3.18	Comparators
		6.3.19	Timer characteristics
		6.3.20	Communications interfaces
		6.3.21	LCD controller 111
7	Pack	age info	ormation
	7.1	LQFP6	4 package information
	7.2	TFBGA	A64 package information117
	7.3	LQFP4	8 package information
	7.4	Therma	al characteristics
		7.4.1	Reference document
8	Part	number	ring 125
9	Revi	sion his	tory



List of tables

Table 1.	Ultra-low-power STM32L053x6/x8 device features and peripheral counts	11
Table 2.	Functionalities depending on the operating power supply range	16
Table 3.	CPU frequency range depending on dynamic voltage scaling	16
Table 4.	Functionalities depending on the working mode	
	(from Run/active down to standby)	
Table 5.	STM32L0xx peripherals interconnect matrix	19
Table 6.	Temperature sensor calibration values	28
Table 7.	Internal voltage reference measured values	28
Table 8.	Capacitive sensing GPIOs available on STM32L053x6/8 devices	30
Table 9.	Timer feature comparison	
Table 10.	Comparison of I2C analog and digital filters	
Table 11.	STM32L053x6/8 I ² C implementation	
Table 12.	USART implementation	
Table 13.	SPI/I2S implementation	
Table 14.	Legend/abbreviations used in the pinout table	
Table 15.	STM32L053x6/8 pin definitions	
Table 16.	Alternate function port A	
Table 17.	Alternate function port B	
Table 18.	Alternate function port C	
Table 19.	Alternate function port D	
Table 20.	Alternate function port H	
Table 21.	Voltage characteristics	
Table 22.	Current characteristics	
Table 23.	Thermal characteristics	
Table 24.	General operating conditions	
Table 25.	Embedded reset and power control block characteristics	
Table 26.	Embedded internal reference voltage calibration values	
Table 27.	Embedded internal reference voltage	
Table 28.	Current consumption in Run mode, code with data processing running from Flash	
Table 29.	Current consumption in Run mode vs code type,	
	code with data processing running from Flash	60
Table 30.	Current consumption in Run mode, code with data processing running from RAM	
Table 31.	Current consumption in Run mode vs code type,	
	code with data processing running from RAM	62
Table 32.	Current consumption in Sleep mode	
Table 33.	Current consumption in Low-power run mode	
Table 34.	Current consumption in Low-power sleep mode	
Table 35.	Typical and maximum current consumptions in Stop mode	
Table 36.	Typical and maximum current consumptions in Standby mode	
Table 37.	Average current consumption during Wakeup	
Table 38.	Peripheral current consumption in Run or Sleep mode	
Table 39.	Peripheral current consumption in Stop and Standby mode	
Table 40.	Low-power mode wakeup timings	
Table 41.	High-speed external user clock characteristics	72
Table 42.	Low-speed external user clock characteristics	
Table 43.	HSE oscillator characteristics	
Table 44.	LSE oscillator characteristics	
Table 45.	16 MHz HSI16 oscillator characteristics	



Table 46.	HSI48 oscillator characteristics77
Table 47.	LSI oscillator characteristics
Table 48.	MSI oscillator characteristics
Table 49.	PLL characteristics
Table 50.	RAM and hardware registers
Table 51.	Flash memory and data EEPROM characteristics
Table 52.	Flash memory and data EEPROM endurance and retention 80
Table 53.	EMS characteristics
Table 54.	EMI characteristics
Table 55.	ESD absolute maximum ratings
Table 56.	Electrical sensitivities
Table 57.	I/O current injection susceptibility
Table 58.	I/O static characteristics
Table 59.	Output voltage characteristics
Table 60.	I/O AC characteristics
Table 61.	NRST pin characteristics
Table 62.	ADC characteristics
Table 63.	R_{AIN} max for f_{ADC} = 16 MHz92
Table 64.	ADC accuracy92
Table 65.	DAC characteristics
Table 66.	Temperature sensor calibration values99
Table 67.	Temperature sensor characteristics
Table 68.	Comparator 1 characteristics
Table 69.	Comparator 2 characteristics
Table 70.	TIMx characteristics
Table 71.	I2C analog filter characteristics
Table 72.	USART/LPUART characteristics
Table 73.	SPI characteristics in voltage Range 1
Table 74.	SPI characteristics in voltage Range 2
Table 75.	SPI characteristics in voltage Range 3
Table 76.	I2S characteristics
Table 77.	USB startup time110
Table 78.	USB DC electrical characteristics
Table 79.	USB: full speed electrical characteristics
Table 80.	LCD controller characteristics111
Table 81.	LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package mechanical data
	package mechanical data
Table 82.	TFBGA64 – 64-ball, 5 x 5 mm, 0.5 mm pitch, thin profile fine pitch ball
	grid array package mechanical data117
Table 83.	TFBGA64 recommended PCB design rules (0.5 mm pitch BGA)
Table 84.	LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package mechanical data
Table 85.	Thermal characteristics123
Table 86.	STM32L053x6/8 ordering information scheme
Table 87.	Document revision history



List of figures

Figure 1.	STM32L053x6/8 block diagram	12
Figure 2.	Clock tree	
Figure 3.	STM32L053x6/8 LQFP64 pinout - 10 x 10 mm	37
Figure 4.	STM32L053x6/8 TFBGA64 ballout - 5x 5 mm	38
Figure 5.	STM32L053x6/8 LQFP48 pinout - 7 x 7 mm	39
Figure 6.	Memory map	49
Figure 7.	Pin loading conditions	50
Figure 8.	Pin input voltage	50
Figure 9.	Power supply scheme	
Figure 10.	Optional LCD power supply scheme	52
Figure 11.	Current consumption measurement scheme	52
Figure 12.	IDD vs VDD, at TA= 25/55/85/105 °C, Run mode, code running from	
_	Flash memory, Range 2, HSE, 1WS	61
Figure 13.	IDD vs VDD, at TA= 25/55/85/105 °C, Run mode, code running from	
_	Flash memory, Range 2, HSI16, 1WS	61
Figure 14.	IDD vs VDD, at TA= 25/55/ 85/105/125 °C, Low-power run mode, code running	
· ·	from RAM, Range 3, MSI (Range 0) at 64 KHz, 0 WS	65
Figure 15.	IDD vs VDD, at TA= 25/55/ 85/105/125 °C, Stop mode with RTC enabled	
· ·	and running on LSE Low drive	66
Figure 16.	IDD vs VDD, at TA= 25/55/85/105/125 °C, Stop mode with RTC disabled,	
Ü	all clocks OFF	66
Figure 17.	High-speed external clock source AC timing diagram	
Figure 18.	Low-speed external clock source AC timing diagram	
Figure 19.	HSE oscillator circuit diagram	
Figure 20.	Typical application with a 32.768 kHz crystal	
Figure 21.	HSI16 minimum and maximum value versus temperature	
Figure 22.	VIH/VIL versus VDD (CMOS I/Os)	
Figure 23.	VIH/VIL versus VDD (TTL I/Os)	
Figure 24.	I/O AC characteristics definition	
Figure 25.	Recommended NRST pin protection	
Figure 26.	ADC accuracy characteristics	
Figure 27.	Typical connection diagram using the ADC	
Figure 28.	Power supply and reference decoupling (V _{REF+} not connected to V _{DDA})	
Figure 29.	Power supply and reference decoupling (V_{REF+} connected to V_{DDA})	
Figure 30.	12-bit buffered/non-buffered DAC	
Figure 31.	SPI timing diagram - slave mode and CPHA = 0	
Figure 32.	SPI timing diagram - slave mode and CPHA = 1 ⁽¹⁾	106
Figure 33.	SPI timing diagram - master mode ⁽¹⁾	107
Figure 34.	I ² S slave timing diagram (Philips protocol) ⁽¹⁾	109
Figure 35.	I ² S master timing diagram (Philips protocol) ⁽¹⁾	109
Figure 36.	USB timings: definition of data signal rise and fall time	111
Figure 37.	LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package outline	
Figure 38.	LQFP64 - 64-pin, 10 x 10 mm low-profile guad flat recommended footprint	
Figure 39.	LQFP64 marking example (package top view)	
Figure 40.	TFBGA64 – 64-ball, 5 x 5 mm, 0.5 mm pitch thin profile fine pitch ball	
gu.	grid array package outline	117
Figure 41.	TFBGA64 – 64-ball, 5 x 5 mm, 0.5 mm pitch, thin profile fine pitch ball	
ga.o - 1.	grid array recommended footprint	118



List of figures

STM32L053x6 STM32L053x8

Figure 42.	TFBGA64 marking example (package top view)	119
Figure 43.	LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package outline	120
Figure 44.	LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat recommended footprint	121
Figure 45.	LQFP48 marking example (package top view)	122
Figure 46.	Thermal resistance	123



1 Introduction

The ultra-low-power STM32L053x6/8 are offered in 3 different package types: from 48 pins to 64 pins. Depending on the device chosen, different sets of peripherals are included, the description below gives an overview of the complete range of peripherals proposed in this family.

These features make the ultra-low-power STM32L053x6/8 microcontrollers suitable for a wide range of applications:

- Gas/water meters and industrial sensors
- Healthcare and fitness equipment
- · Remote control and user interface
- PC peripherals, gaming, GPS equipment
- Alarm system, wired and wireless sensors, video intercom

This STM32L053x6/8 datasheet should be read in conjunction with the STM32L0x3xx reference manual (RM0367).

For information on the ARM[®] Cortex[®]-M0+ core please refer to the Cortex[®]-M0+ Technical Reference Manual, available from the www.arm.com website.

Figure 1 shows the general block diagram of the device family.



2 Description

The ultra-low-power STM32L053x6/8 microcontrollers incorporate the connectivity power of the universal serial bus (USB 2.0 crystal-less) with the high-performance ARM® Cortex®-M0+ 32-bit RISC core operating at a 32 MHz frequency, a memory protection unit (MPU), high-speed embedded memories (up to 64 Kbytes of Flash program memory, 2 Kbytes of data EEPROM and 8 Kbytes of RAM) plus an extensive range of enhanced I/Os and peripherals.

The STM32L053x6/8 devices provide high power efficiency for a wide range of performance. It is achieved with a large choice of internal and external clock sources, an internal voltage adaptation and several low-power modes.

The STM32L053x6/8 devices offer several analog features, one 12-bit ADC with hardware oversampling, one DAC, two ultra-low-power comparators, several timers, one low-power timer (LPTIM), three general-purpose 16-bit timers and one basic timer, one RTC and one SysTick which can be used as timebases. They also feature two watchdogs, one watchdog with independent clock and window capability and one window watchdog based on bus clock.

Moreover, the STM32L053x6/8 devices embed standard and advanced communication interfaces: up to two I2C, two SPIs, one I2S, two USARTs, a low-power UART (LPUART), and a crystal-less USB. The devices offer up to 24 capacitive sensing channels to simply add touch sensing functionality to any application.

The STM32L053x6/8 also include a real-time clock and a set of backup registers that remain powered in Standby mode.

Finally, their integrated LCD controller has a built-in LCD voltage generator that allows to drive up to 8 multiplexed LCDs with contrast independent of the supply voltage.

The ultra-low-power STM32L053x6/8 devices operate from a 1.8 to 3.6 V power supply (down to 1.65 V at power down) with BOR and from a 1.65 to 3.6 V power supply without BOR option. They are available in the -40 to +125 °C temperature range. A comprehensive set of power-saving modes allows the design of low-power applications.







10/132 DocID025844 Rev 7



2.1 Device overview

Table 1. Ultra-low-power STM32L053x6/x8 device features and peripheral counts

Peripheral		STM32L053C6		STM32L053C8		
Flash (Kbytes)		32		64		
Data EEPROM (Kbytes)		2	2	2		
RAM (Kbytes)		8	3	8	3	
	General-purpose	;	3	;	3	
Timers	Basic	,	1	,	1	
	LPTIMER	,	1	,	1	
RTC/SYSTICK	/IWDG/WWDG	1/1/	/1/1	1/1/	/1/1	
	SPI/I2S	4(2)	⁽¹⁾ /1	4(2)	⁽¹⁾ /1	
	I ² C	2	2	2	2	
Communication interfaces	USART	-	2	-	2	
	LPUART	1		,	1	
	USB/(VDD_USB)	1/(1)		1/0	(1)	
GPIOs		37	51 ⁽²⁾	37	51 ⁽²⁾	
Clocks: HSE/LSE/HS	I/MSI/LSI	1/1/1/1		1/1/1/1		
12-bit synchronized A	ADC	1 10	1 16 ⁽²⁾	1 10	1 16 ⁽²⁾	
12-bit DAC Number of channels		1 1			1	
LCD COM x SEG		1 4x18	1 4x32 or 8x28 ⁽²⁾	1 4x18	1 4x32 or 8x28 ⁽²⁾	
Comparators		2		2		
Capacitive sensing c	hannels	17	24 ⁽²⁾	17	24 ⁽²⁾	
Max. CPU frequency		32 MHz				
Operating voltage		1.8 V to 3.6 V (down to 1.65 V at power-down) with BOR option 1.65 V to 3.6 V without BOR option				
Operating temperatu	res	Ambient temperature: -40 to +125 °C Junction temperature: -40 to +130 °C				
Packages		LQFP48	LQFP64, TFBGA64	LQFP48	LQFP64, TFBGA64	

^{1. 2} SPI interfaces are USARTs operating in SPI master mode.

^{2.} TFBGA64 has one GPIO, one LCD COM x SEG, one ADC input and one capacitive sensing channel less than LQFP64.

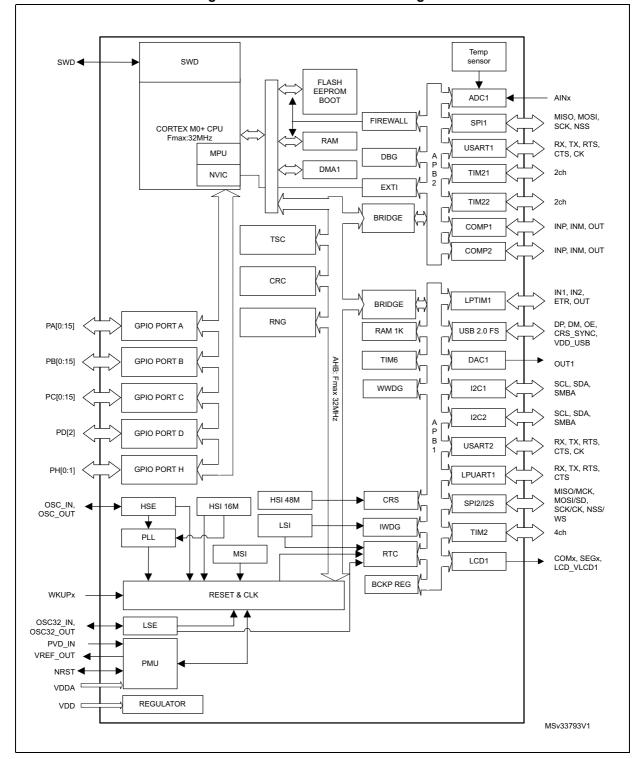


Figure 1. STM32L053x6/8 block diagram



2.2 Ultra-low-power device continuum

The ultra-low-power family offers a large choice of core and features, from 8-bit proprietary core up to ARM® Cortex®-M4, including ARM® Cortex®-M3 and ARM® Cortex®-M0+. The STM32Lx series are the best choice to answer your needs in terms of ultra-low-power features. The STM32 ultra-low-power series are the best solution for applications such as gaz/water meter, keyboard/mouse or fitness and healthcare application. Several built-in features like LCD drivers, dual-bank memory, low-power run mode, operational amplifiers, 128-bit AES, DAC, crystal-less USB and many other definitely help you building a highly cost optimized application by reducing BOM cost. STMicroelectronics, as a reliable and long-term manufacturer, ensures as much as possible pin-to-pin compatibility between all STM8Lx and STM32Lx on one hand, and between all STM32Lx and STM32Fx on the other hand. Thanks to this unprecedented scalability, your legacy application can be upgraded to respond to the latest market feature and efficiency requirements.



Functional overview 3

3.1 Low-power modes

The ultra-low-power STM32L053x6/8 support dynamic voltage scaling to optimize its power consumption in Run mode. The voltage from the internal low-drop regulator that supplies the logic can be adjusted according to the system's maximum operating frequency and the external voltage supply.

There are three power consumption ranges:

- Range 1 (V_{DD} range limited to 1.71-3.6 V), with the CPU running at up to 32 MHz
- Range 2 (full V_{DD} range), with a maximum CPU frequency of 16 MHz
- Range 3 (full V_{DD} range), with a maximum CPU frequency limited to 4.2 MHz

Seven low-power modes are provided to achieve the best compromise between low-power consumption, short startup time and available wakeup sources:

Sleep mode

In Sleep mode, only the CPU is stopped. All peripherals continue to operate and can wake up the CPU when an interrupt/event occurs. Sleep mode power consumption at 16 MHz is about 1 mA with all peripherals off.

Low-power run mode

This mode is achieved with the multispeed internal (MSI) RC oscillator set to the lowspeed clock (max 131 kHz), execution from SRAM or Flash memory, and internal regulator in low-power mode to minimize the regulator's operating current. In Lowpower run mode, the clock frequency and the number of enabled peripherals are both limited.

Low-power sleep mode

This mode is achieved by entering Sleep mode with the internal voltage regulator in low-power mode to minimize the regulator's operating current. In Low-power sleep mode, both the clock frequency and the number of enabled peripherals are limited; a typical example would be to have a timer running at 32 kHz.

When wakeup is triggered by an event or an interrupt, the system reverts to the Run mode with the regulator on.

Stop mode with RTC

The Stop mode achieves the lowest power consumption while retaining the RAM and register contents and real time clock. All clocks in the V_{CORE} domain are stopped, the PLL, MSI RC, HSE crystal and HSI RC oscillators are disabled. The LSE or LSI is still running. The voltage regulator is in the low-power mode.

Some peripherals featuring wakeup capability can enable the HSI RC during Stop mode to detect their wakeup condition.

The device can be woken up from Stop mode by any of the EXTI line, in 3.5 µs, the processor can serve the interrupt or resume the code. The EXTI line source can be any GPIO. It can be the PVD output, the comparator 1 event or comparator 2 event (if internal reference voltage is on), it can be the RTC alarm/tamper/timestamp/wakeup events, the USB/USART/I2C/LPUART/LPTIMER wakeup events.

14/132 DocID025844 Rev 7



Stop mode without RTC

The Stop mode achieves the lowest power consumption while retaining the RAM and register contents. All clocks are stopped, the PLL, MSI RC, HSI and LSI RC, HSE and LSE crystal oscillators are disabled.

Some peripherals featuring wakeup capability can enable the HSI RC during Stop mode to detect their wakeup condition.

The voltage regulator is in the low-power mode. The device can be woken up from Stop mode by any of the EXTI line, in 3.5 μ s, the processor can serve the interrupt or resume the code. The EXTI line source can be any GPIO. It can be the PVD output, the comparator 1 event or comparator 2 event (if internal reference voltage is on). It can also be wakened by the USB/USART/I2C/LPUART/LPTIMER wakeup events.

Standby mode with RTC

The Standby mode is used to achieve the lowest power consumption and real time clock. The internal voltage regulator is switched off so that the entire V_{CORE} domain is powered off. The PLL, MSI RC, HSE crystal and HSI RC oscillators are also switched off. The LSE or LSI is still running. After entering Standby mode, the RAM and register contents are lost except for registers in the Standby circuitry (wakeup logic, IWDG, RTC, LSI, LSE Crystal 32 KHz oscillator, RCC_CSR register).

The device exits Standby mode in 60 µs when an external reset (NRST pin), an IWDG reset, a rising edge on one of the three WKUP pins, RTC alarm (Alarm A or Alarm B), RTC tamper event, RTC timestamp event or RTC Wakeup event occurs.

Standby mode without RTC

The Standby mode is used to achieve the lowest power consumption. The internal voltage regulator is switched off so that the entire V_{CORE} domain is powered off. The PLL, MSI RC, HSI and LSI RC, HSE and LSE crystal oscillators are also switched off. After entering Standby mode, the RAM and register contents are lost except for registers in the Standby circuitry (wakeup logic, IWDG, RTC, LSI, LSE Crystal 32 KHz oscillator, RCC_CSR register).

The device exits Standby mode in 60 µs when an external reset (NRST pin) or a rising edge on one of the three WKUP pin occurs.

Note:

The RTC, the IWDG, and the corresponding clock sources are not stopped automatically by entering Stop or Standby mode. The LCD is not stopped automatically by entering Stop mode.



Table 2. Functionalities depending on the operating power supply range

	Functionalities depending on the operating power supply range						
Operating power supply range	DAC and ADC operation	Dynamic voltage scaling range	I/O operation	USB			
V _{DD} = 1.65 to 1.71 V	ADC only, conversion time up to 570 ksps	Range 2 or range 3	Degraded speed performance	Not functional			
V _{DD} = 1.71 to 1.8 V ⁽¹⁾	ADC only, conversion time up to 1.14 Msps	Range 1, range 2 or range 3	Degraded speed performance	Functional ⁽²⁾			
V_{DD} = 1.8 to 2.0 $V^{(1)}$	Conversion time up to 1.14 Msps	Range1, range 2 or range 3	Degraded speed performance	Functional ⁽²⁾			
V _{DD} = 2.0 to 2.4 V	Conversion time up to 1.14 Msps	Range 1, range 2 or range 3	Full speed operation	Functional ⁽²⁾			
V _{DD} = 2.4 to 3.6 V	Conversion time up to 1.14 Msps	Range 1, range 2 or range 3	Full speed operation	Functional ⁽²⁾			

^{1.} CPU frequency changes from initial to final must respect "fcpu initial <4*fcpu final". It must also respect 5 μs delay between two changes. For example to switch from 4.2 MHz to 32 MHz, you can switch from 4.2 MHz to 16 MHz, wait 5 μs , then switch from 16 MHz to 32 MHz.

Table 3. CPU frequency range depending on dynamic voltage scaling

CPU frequency range	Dynamic voltage scaling range
16 MHz to 32 MHz (1ws) 32 kHz to 16 MHz (0ws)	Range 1
8 MHz to 16 MHz (1ws) 32 kHz to 8 MHz (0ws)	Range 2
32 kHz to 4.2 MHz (0ws)	Range 3

16/132 DocID025844 Rev 7

^{2.} To be USB compliant from the I/O voltage standpoint, the minimum $\rm V_{\rm DD_USB}$ is 3.0 V.

Table 4. Functionalities depending on the working mode (from Run/active down to standby) ⁽¹⁾

			Low-	Low-	Stop		5	Standby
IPs	Run/Active	Sleep	power run	power sleep		Wakeup capability		Wakeup capability
CPU	Υ		Υ					
Flash memory	0	0	0	0				
RAM	Y	Y	Y	Y	Υ			
Backup registers	Y	Υ	Υ	Y	Υ		Υ	
EEPROM	0	0	0	0			I	
Brown-out reset (BOR)	0	0	0	0	0	0	0	0
DMA	0	0	0	0				
Programmable Voltage Detector (PVD)	0	0	0	0	0	0	-	
Power-on/down reset (POR/PDR)	Υ	Y	Y	Y	Υ	Y	Υ	Y
High Speed Internal (HSI)	0	0			(2)			
High Speed External (HSE)	0	0	0	0				
Low Speed Internal (LSI)	0	0	0	0	0		0	
Low Speed External (LSE)	0	0	0	0	0		0	
Multi-Speed Internal (MSI)	0	0	Y	Υ				
Inter-Connect Controller	Y	Y	Υ	Υ	Υ			
RTC	0	0	0	0	0	0	0	
RTC Tamper	0	0	0	0	0	0	0	0
Auto WakeUp (AWU)	0	О	0	0	0	0	0	0
LCD	0	0	0	0	0			
USB	0	0				0		
USART	0	0	0	0	O ⁽³⁾	0		
LPUART	0	0	0	0	O ⁽³⁾	0		
SPI	0	0	0	0				
I2C	0	0	0	0	O ⁽⁴⁾	0		
ADC	0	0						



Table 4. Functionalities depending on the working mode (from Run/active down to standby) (continued)(1)

			Low-	Low-		Stop		Standby
IPs	Run/Active	Sleep	power run	power sleep		Wakeup capability		Wakeup capability
DAC	0	0	0	0	0			
Temperature sensor	0	0	0	0	0			
Comparators	0	0	0	0	0	0		
16-bit timers	0	0	0	0				
LPTIMER	0	0	0	0	0	0		
IWDG	0	0	0	0	0	0	0	0
WWDG	0	0	0	0			-	
Touch sensing controller (TSC)	0	0						
SysTick Timer	0	0	0	0			-	
GPIOs	0	0	0	0	0	0		2 pins
Wakeup time to Run mode	0 μs	0.36 µs	3 µs	32 µs	3.5 µs		50 μs	
						4 μΑ (No) V _{DD} =1.8 V		
Consumption V _{DD} =1.8 to 3.6 V	Down to 140 μA/MHz (from Flash memory)	Down to 37 µA/MHz	Down to 8 μA	Down to	0.8 μA (with RTC) V _{DD} =1.8 V		0.65 μA (with RTC) V _{DD} =1.8 V	
(Typ)		(from Flash memory)		4.5 µA	0.4 μA (No RTC) V _{DD} =3.0 V		0.29 μA (No RTC) V _{DD} =3.0 V	
						(with RTC) OD=3.0 V		5 μA (with) V _{DD} =3.0 V

DocID025844 Rev 7 18/132

Legend:
 "Y" = Yes (enable).
 "O" = Optional can be enabled/disabled by software)
 "-" = Not available

^{2.} Some peripherals with wakeup from Stop capability can request HSI to be enabled. In this case, HSI is woken up by the peripheral, and only feeds the peripheral which requested it. HSI is automatically put off when the peripheral does not need it anymore.

^{3.} UART and LPUART reception is functional in Stop mode. It generates a wakeup interrupt on Start. To generate a wakeup on address match or received frame event, the LPUART can run on LSE clock while the UART has to wake up or keep running the HSI clock.

I2C address detection is functional in Stop mode. It generates a wakeup interrupt in case of address match. It will wake up the HSI during reception.

3.2 Interconnect matrix

Several peripherals are directly interconnected. This allows autonomous communication between peripherals, thus saving CPU resources and power consumption. In addition, these hardware connections allow fast and predictable latency.

Depending on peripherals, these interconnections can operate in Run, Sleep, Low-power run, Low-power sleep and Stop modes.

Table 5. STM32L0xx peripherals interconnect matrix

Interconnect source	Interconnect destination	Interconnect action	Run	Sleep	Low- power run	Low- power sleep	Stop
COMPx	TIM2,TIM21, TIM22	Timer input channel, trigger from analog signals comparison	Y	Y	Υ	Y	-
	LPTIM	Timer input channel, trigger from analog signals comparison	Y	Y	Υ	Y	Υ
TIMx	TIMx	Timer triggered by other timer	Y	Y	Y	Y	-
RTC	TIM21	Timer triggered by Auto wake-up	Y	Y	Y	Y	-
	LPTIM	Timer triggered by RTC event	Y	Y	Υ	Y	Υ
All clock source	TIMx	Clock source used as input channel for RC measurement and trimming	Y	Y	Y	Y	-
USB	CRS/HSI48	the clock recovery system trims the HSI48 based on USB SOF	Y	Y	1	-	-
GPIO	TIMx	Timer input channel and trigger	Y	Y	Y	Y	-
	LPTIM	Timer input channel and trigger	Y	Y	Y	Y	Υ
	ADC,DAC	Conversion trigger	Υ	Υ	Υ	Y	-

ARM® Cortex®-M0+ core with MPU 3.3

The Cortex-M0+ processor is an entry-level 32-bit ARM Cortex processor designed for a broad range of embedded applications. It offers significant benefits to developers, including:

- a simple architecture that is easy to learn and program
- ultra-low power, energy-efficient operation
- excellent code density
- deterministic, high-performance interrupt handling
- upward compatibility with Cortex-M processor family
- platform security robustness, with integrated Memory Protection Unit (MPU).

The Cortex-M0+ processor is built on a highly area and power optimized 32-bit processor core, with a 2-stage pipeline Von Neumann architecture. The processor delivers exceptional energy efficiency through a small but powerful instruction set and extensively optimized design, providing high-end processing hardware including a single-cycle multiplier.

The Cortex-M0+ processor provides the exceptional performance expected of a modern 32bit architecture, with a higher code density than other 8-bit and 16-bit microcontrollers.

Owing to its embedded ARM core, the STM32L053x6/8 are compatible with all ARM tools and software.

Nested vectored interrupt controller (NVIC)

The ultra-low-power STM32L053x6/8 embed a nested vectored interrupt controller able to handle up to 32 maskable interrupt channels and 4 priority levels.

The Cortex-M0+ processor closely integrates a configurable Nested Vectored Interrupt Controller (NVIC), to deliver industry-leading interrupt performance. The NVIC:

- includes a Non-Maskable Interrupt (NMI)
- provides zero jitter interrupt option
- provides four interrupt priority levels

The tight integration of the processor core and NVIC provides fast execution of Interrupt Service Routines (ISRs), dramatically reducing the interrupt latency. This is achieved through the hardware stacking of registers, and the ability to abandon and restart loadmultiple and store-multiple operations. Interrupt handlers do not require any assembler wrapper code, removing any code overhead from the ISRs. Tail-chaining optimization also significantly reduces the overhead when switching from one ISR to another.

To optimize low-power designs, the NVIC integrates with the sleep modes, that include a deep sleep function that enables the entire device to enter rapidly stop or standby mode.

This hardware block provides flexible interrupt management features with minimal interrupt latency.

20/132 DocID025844 Rev 7



3.4 Reset and supply management

3.4.1 Power supply schemes

- V_{DD} = 1.65 to 3.6 V: external power supply for I/Os and the internal regulator. Provided externally through V_{DD} pins.
- V_{SSA} , V_{DDA} = 1.65 to 3.6 V: external analog power supplies for ADC, DAC, reset blocks, RCs and PLL (minimum voltage to be applied to V_{DDA} is 1.8 V when the DAC is used). V_{DDA} and V_{SSA} must be connected to V_{DD} and V_{SS} , respectively.
- V_{DD_USB} = 1.65 to 3.6V: external power supply for USB transceiver, USB_DM (PA11) and USB_DP (PA12). To guarantee a correct voltage level for USB communication V_{DD_USB} must be above 3.0V. If USB is not used this pin must be tied to V_{DD}.

3.4.2 Power supply supervisor

The devices have an integrated ZEROPOWER power-on reset (POR)/power-down reset (PDR) that can be coupled with a brownout reset (BOR) circuitry.

Two versions are available:

- The version with BOR activated at power-on operates between 1.8 V and 3.6 V.
- The other version without BOR operates between 1.65 V and 3.6 V.

After the V_{DD} threshold is reached (1.65 V or 1.8 V depending on the BOR which is active or not at power-on), the option byte loading process starts, either to confirm or modify default thresholds, or to disable the BOR permanently: in this case, the VDD min value becomes 1.65 V (whatever the version, BOR active or not, at power-on).

When BOR is active at power-on, it ensures proper operation starting from 1.8 V whatever the power ramp-up phase before it reaches 1.8 V. When BOR is not active at power-up, the power ramp-up should guarantee that 1.65 V is reached on V_{DD} at least 1 ms after it exits the POR area.

Five BOR thresholds are available through option bytes, starting from 1.8 V to 3 V. To reduce the power consumption in Stop mode, it is possible to automatically switch off the internal reference voltage (V_{REFINT}) in Stop mode. The device remains in reset mode when V_{DD} is below a specified threshold, $V_{POR/PDR}$ or V_{BOR} , without the need for any external reset circuit.

Note:

The start-up time at power-on is typically 3.3 ms when BOR is active at power-up, the start-up time at power-on can be decreased down to 1 ms typically for devices with BOR inactive at power-up.

The devices feature an embedded programmable voltage detector (PVD) that monitors the $V_{DD/VDDA}$ power supply and compares it to the V_{PVD} threshold. This PVD offers 7 different levels between 1.85 V and 3.05 V, chosen by software, with a step around 200 mV. An interrupt can be generated when $V_{DD/VDDA}$ drops below the V_{PVD} threshold and/or when $V_{DD/VDDA}$ is higher than the V_{PVD} threshold. The interrupt service routine can then generate a warning message and/or put the MCU into a safe state. The PVD is enabled by software.

3.4.3 Voltage regulator

The regulator has three operation modes: main (MR), low power (LPR) and power down.

- MR is used in Run mode (nominal regulation)
- LPR is used in the Low-power run, Low-power sleep and Stop modes
- Power down is used in Standby mode. The regulator output is high impedance, the kernel circuitry is powered down, inducing zero consumption but the contents of the registers and RAM are lost except for the standby circuitry (wakeup logic, IWDG, RTC, LSI, LSE crystal 32 KHz oscillator, RCC CSR).

3.5 Clock management

The clock controller distributes the clocks coming from different oscillators to the core and the peripherals. It also manages clock gating for low-power modes and ensures clock robustness. It features:

Clock prescaler

To get the best trade-off between speed and current consumption, the clock frequency to the CPU and peripherals can be adjusted by a programmable prescaler.

Safe clock switching

Clock sources can be changed safely on the fly in Run mode through a configuration register.

Clock management

To reduce power consumption, the clock controller can stop the clock to the core, individual peripherals or memory.

System clock source

Three different clock sources can be used to drive the master clock SYSCLK:

- 1-25 MHz high-speed external crystal (HSE), that can supply a PLL
- 16 MHz high-speed internal RC oscillator (HSI), trimmable by software, that can supply a PLLMultispeed internal RC oscillator (MSI), trimmable by software, able to generate 7 frequencies (65 kHz, 131 kHz, 262 kHz, 524 kHz, 1.05 MHz, 2.1 MHz, 4.2 MHz). When a 32.768 kHz clock source is available in the system (LSE), the MSI frequency can be trimmed by software down to a ±0.5% accuracy.

Auxiliary clock source

Two ultra-low-power clock sources that can be used to drive the LCD controller and the real-time clock:

- 32.768 kHz low-speed external crystal (LSE)
- 37 kHz low-speed internal RC (LSI), also used to drive the independent watchdog.
 The LSI clock can be measured using the high-speed internal RC oscillator for greater precision.

RTC and LCD clock sources

The LSI, LSE or HSE sources can be chosen to clock the RTC and the LCD, whatever the system clock.

USB clock source

A 48 MHz clock trimmed through the USB SOF supplies the USB interface.

577

22/132 DocID025844 Rev 7

Startup clock

After reset, the microcontroller restarts by default with an internal 2 MHz clock (MSI). The prescaler ratio and clock source can be changed by the application program as soon as the code execution starts.

Clock security system (CSS)

This feature can be enabled by software. If an HSE clock failure occurs, the master clock is automatically switched to HSI and a software interrupt is generated if enabled. Another clock security system can be enabled, in case of failure of the LSE it provides an interrupt or wakeup event which is generated if enabled.

Clock-out capability (MCO: microcontroller clock output)
 It outputs one of the internal clocks for external use by the application.

Several prescalers allow the configuration of the AHB frequency, each APB (APB1 and APB2) domains. The maximum frequency of the AHB and the APB domains is 32 MHz. See *Figure 2* for details on the clock tree.



@V33 Enable Watchdog Watchdog LS Legend: HSE = High-speed external clock signal LSI RC LSI tempo HSI = High-speed internal clock signal RŢCSEL LSI = Low-speed internal clock signal LSE = Low-speed external clock signal RTC2 enable MSI = Multispeed internal clock signal RTC LSE OSC LSE tempo LCD enable LSU LSD LSD LSD 1 MHz @V18 LCDCLK @V33 MCOSEL ADC enable LSI ADCCLK MSI RC MSI Level shifters **►** MCO / 1,2,4,8,16 @V18 not deepsleep / 2,4,8,16 @V33 CK_PWR not deepsleep HSI16 RC լrchs_г HSI16 / 1,4 **FCLK** Level shifters not (sleep or deepsleep) System Clock HCLK I not (sleep or / 8 MSI SysTick I @V33 Timer HSI16 AHB HSE OSC **PRESC** @V3\PLLCLK HSE PCLK1 to APB1 Level shifters / 1,2,..., 512 32 MHz APB1 @V18 max. PRESC 1,2,4,8,16 ILSU 4 X 3,4,6,8,12,16, Peripheral @V33 clock enable 24,32,48 to TIMxi 1 MHz Clock If (APB1 presc=1) x1 else x2) / 2,3,4 Detector Level shifters @V_{DDCORE} HSE present or not Peripheral clock enable PCLK2 to APB2 Clock LSD Source Dedicated 48MHz PLL output peripherals APB2 Control max HSI48MSEL PRESC / 1,2,4,8,16 Peripheral @V33 clock enable to TIMx RC 48MHz If (APB2 presc=1) x1 HSI48 else x2) Level shifters @V18 📥 Peripheral LSI clock enable **SYSCLK** Clock Recovery **LPTIMCLK** System Peripheral **LSE** clock enable HSI16 LPUART/ **PCLK** Peripheral clock enable UARTCLK I2C1CLK usb en 48MHz USBCLK rng en 48MHz RNG MS32912V2

Figure 2. Clock tree



3.6 Low-power real-time clock and backup registers

The real time clock (RTC) and the 5 backup registers are supplied in all modes including standby mode. The backup registers are five 32-bit registers used to store 20 bytes of user application data. They are not reset by a system reset, or when the device wakes up from Standby mode.

The RTC is an independent BCD timer/counter. Its main features are the following:

- Calendar with subsecond, seconds, minutes, hours (12 or 24 format), week day, date, month, year, in BCD (binary-coded decimal) format
- Automatically correction for 28, 29 (leap year), 30, and 31 day of the month
- Two programmable alarms with wake up from Stop and Standby mode capability
- Periodic wakeup from Stop and Standby with programmable resolution and period
- On-the-fly correction from 1 to 32767 RTC clock pulses. This can be used to synchronize it with a master clock.
- Reference clock detection: a more precise second source clock (50 or 60 Hz) can be used to enhance the calendar precision.
- Digital calibration circuit with 1 ppm resolution, to compensate for quartz crystal inaccuracy
- 2 anti-tamper detection pins with programmable filter. The MCU can be woken up from Stop and Standby modes on tamper event detection.
- Timestamp feature which can be used to save the calendar content. This function can be triggered by an event on the timestamp pin, or by a tamper event. The MCU can be woken up from Stop and Standby modes on timestamp event detection.

The RTC clock sources can be:

- A 32.768 kHz external crystal
- A resonator or oscillator
- The internal low-power RC oscillator (typical frequency of 37 kHz)
- The high-speed external clock

3.7 General-purpose inputs/outputs (GPIOs)

Each of the GPIO pins can be configured by software as output (push-pull or open-drain), as input (with or without pull-up or pull-down) or as peripheral alternate function. Most of the GPIO pins are shared with digital or analog alternate functions, and can be individually remapped using dedicated alternate function registers. All GPIOs are high current capable. Each GPIO output, speed can be slowed (40 MHz, 10 MHz, 2 MHz, 400 kHz). The alternate function configuration of I/Os can be locked if needed following a specific sequence in order to avoid spurious writing to the I/O registers. The I/O controller is connected to a dedicated IO bus with a toggling speed of up to 32 MHz.

Extended interrupt/event controller (EXTI)

The extended interrupt/event controller consists of 28 edge detector lines used to generate interrupt/event requests. Each line can be individually configured to select the trigger event (rising edge, falling edge, both) and can be masked independently. A pending register maintains the status of the interrupt requests. The EXTI can detect an external line with a pulse width shorter than the Internal APB2 clock period. Up to 51 GPIOs can be connected to the 16 configurable interrupt/event lines. The 12 other lines are connected to PVD, RTC, USB, USARTs, LPUART, LPTIMER or comparator events.

